

Notice of References CitedApplication No.
09/045,041

Applicant(s)

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Examiner

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2763

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U.S. PATENT DOCUMENTS

	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
A	4,882,690	11/1989	Shinsha et al.	716	18
B	5,473,546	12/1995	Filseth	716	8
C					
D					
E					
F					
G					
H					
I					
J					
K					
L					
M					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
N						
O						
P						
Q						
R						
S						
T						

NON-PATENT DOCUMENTS

	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
U	Kuehlmann et al.; "Equivalence checking using cuts and heaps"; IEEE Proc. 1997 Design Auto. Conf.; pp. 263-268.	6/1997
V	Wang et al.; "Restructuring binary decision diagrams based on functional equivalence"; IEEE Design Automation; pp. 261-265	2/1993
W		
X		